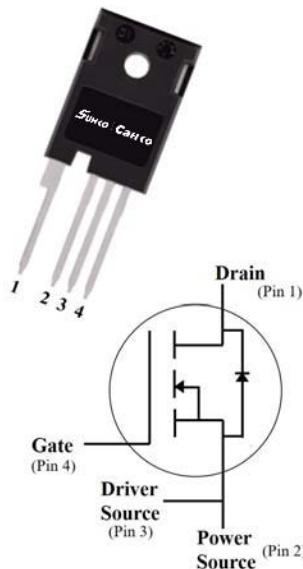


**Silicon Carbide Power MOSFET (N-Channel Enhancement)**

$V_{DS}$	1200V
$I_D(25^\circ\text{C})$	66A
$R_{DS(on)}$	33mΩ

**Features**

- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free,

**Typical Applications**

Typical applications are in power factor correction(PFC), solar inverter, uninterruptible power supply, motor drives, photovoltaic inverter, electric car and charger.

**Mechanical Data**

- **Package:** TO247-4L
- **Terminals:** Tin plated leads
- **Polarity:** As marked

**■Maximum Ratings ( $T_c=25^\circ\text{C}$  Unless otherwise specified)**

PARAMETER	SYMBOL	UNIT	VALUE	TEST CONDITIONS	NOTE
Device marking code				D212040NCFG2	
Drain source voltage @ $T_j=25^\circ\text{C}$	$V_{DS,max}$	V	1200	$V_{GS}=0\text{ V}, I_D=100\mu\text{A}$	
Gate source voltage @ $T_j=25^\circ\text{C}$	$V_{GS,max}$	V	-8/+19	Absolute maximum values	
Gate source voltage @ $T_j=25^\circ\text{C}$	$V_{GS,op}$	V	-4/+15	Recommended operational values	Note1、2
Continuous drain current @ $T_c=25^\circ\text{C}$	$I_D$	A	66	$V_{GS}=15\text{V}, T_c=25^\circ\text{C}$	Fig.18
Continuous drain current @ $T_c=100^\circ\text{C}$			48	$V_{GS}=15\text{V}, T_c=100^\circ\text{C}$	
Pulsed drain current	$I_{D(pulsed)}$	A	120	Pulse width $t_p$ limited by $T_{j,max}$	Fig.23
Avalanche energy, Single Pulse	$E_{AS}$	mJ	500	$V_{DD}=75\text{V}, L=10\text{mH}$	
Power Dissipation	$P_{TOT}$	W	333	$T_c=25^\circ\text{C}, T_j = 175^\circ\text{C}$	Fig.17
Power Dissipation			144	$T_c=110^\circ\text{C}, T_j = 175^\circ\text{C}$	
Operating junction and Storage temperature range	$T_j, T_{stg}$	°C	-55 to +175		
Soldering temperature	$T_L$	°C	260	1.6mm (0.063") from case for 10s	
Mounting torque	$T_M$	Nm	0.6	M3 screw Maximum of mounting process: 3	



Turn off delay time	$t_{d(off)}$	ns		15		$V_{DD}=800V, V_{GS}=-4/+15V, I_D=40A, R_g=2.7\Omega, L=100\mu H$	Fig.21, 20
Fall time	$t_f$			10			

**■ Body diode characteristics** ( $T_c=25^\circ C$  unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note	
Diode forward voltage	$V_{SD}$	V		5.0		$V_{GS}=-4V, I_{SD}=20A$	Fig.8	
				3.3		$V_{GS}=0V, I_{SD}=20A, T_j=175^\circ C$	Fig.9	
Continuous diode forward current	$I_s$	A		66		$T_c=25^\circ C$	Note 1	
Reverse recovery time	$trr$	nS		27		$V_R=800V, V_{GS}=-4V, I_D=40A, \frac{di}{dt}=2250A/\mu S$		
Reverse recovery charge	$Qrr$	nC		478				
Peak reverse recovery current	$I_{rrm}$	A		27				

Note 1: When using SiC Body Diode the maximum recommended  $V_{GS} = -4V$

Note 2: MOSFET can also safely operate at 0/15 V

**■ Thermal Characteristics** ( $T_a=25^\circ C$  Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Typ.
Thermal resistance	$R_{\theta J-C}$	$^\circ C/W$	0.45

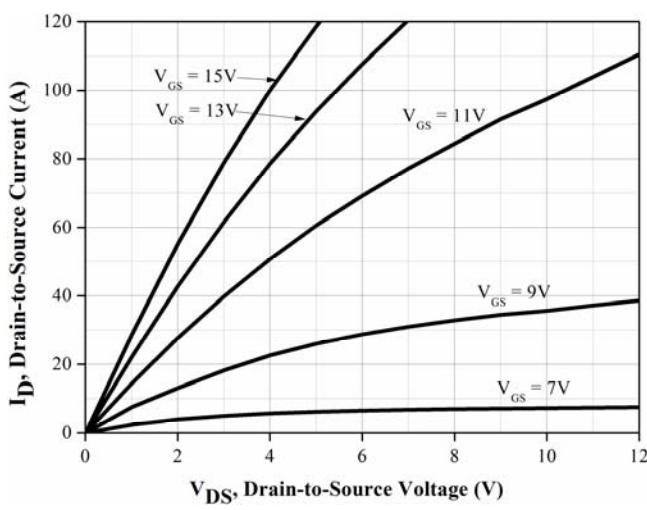
**■ Typical Characteristics**


Figure 1. Output Characteristics  $T_j = -55^\circ C$

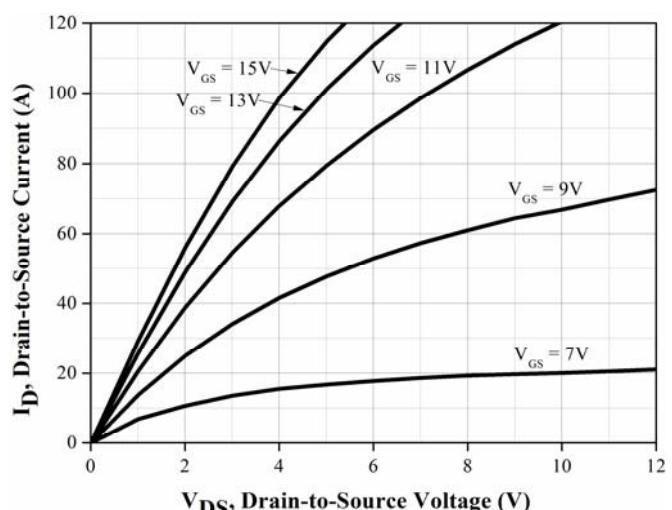


Figure 2. Output Characteristics  $T_j = 25^\circ C$

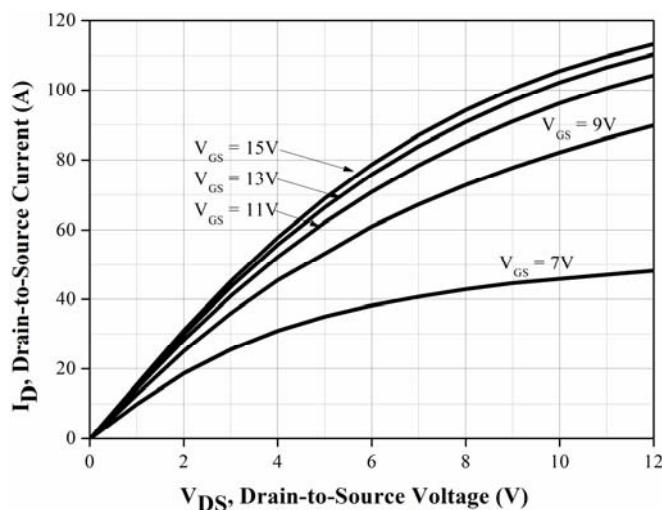
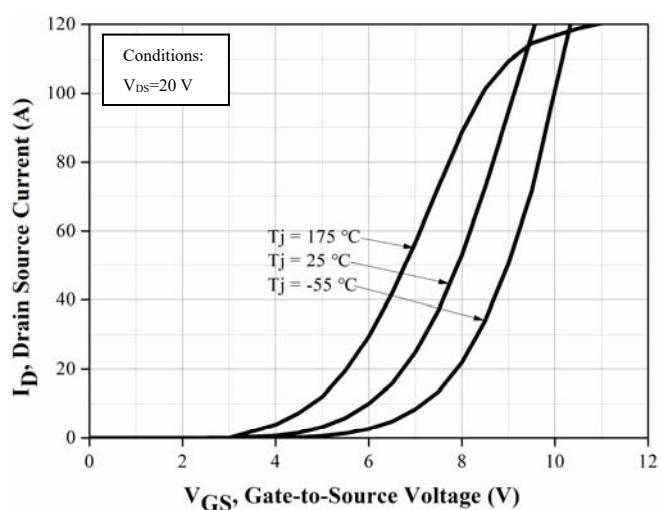
Figure 3. Output Characteristics  $T_j = 175^\circ\text{C}$ 

Figure 4. Transfer Characteristics for various junction temperature

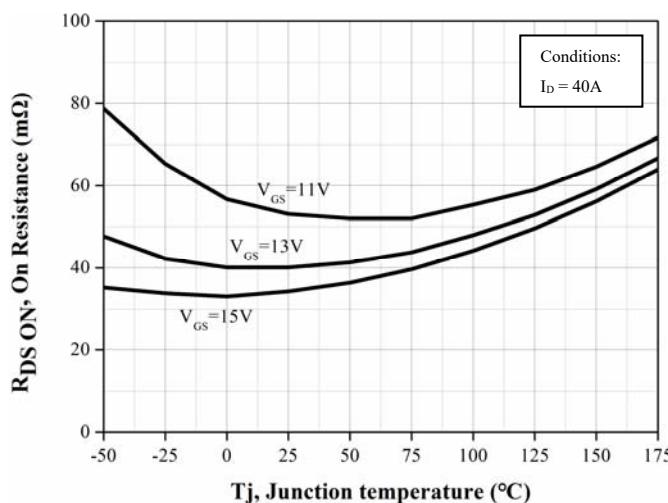


Figure 5. On-resistance vs. temperature for various gate voltage

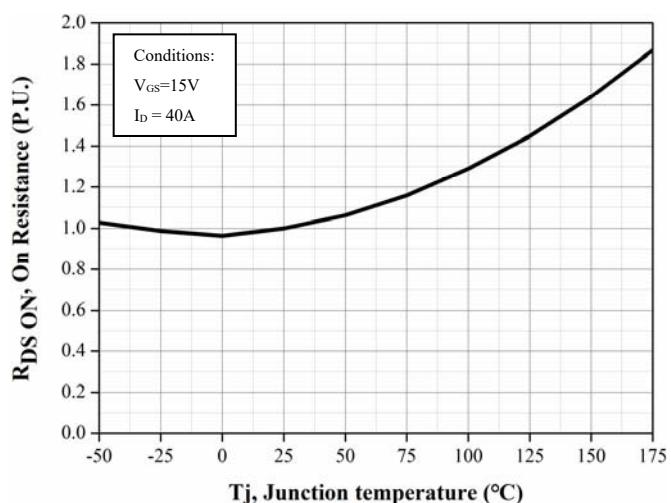


Figure 6. Normalized on-resistance vs. temperature

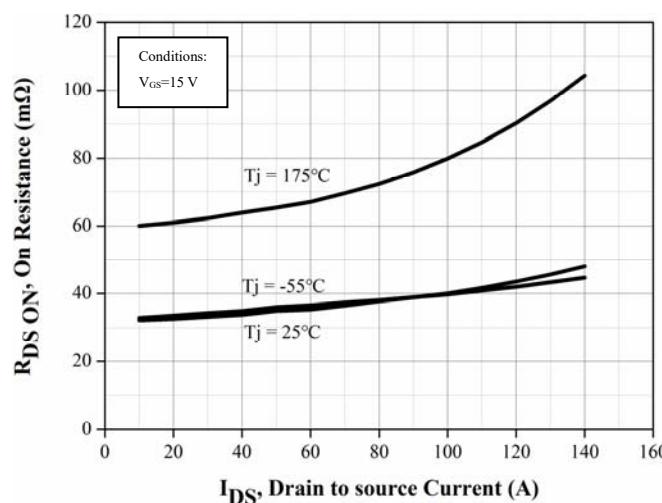
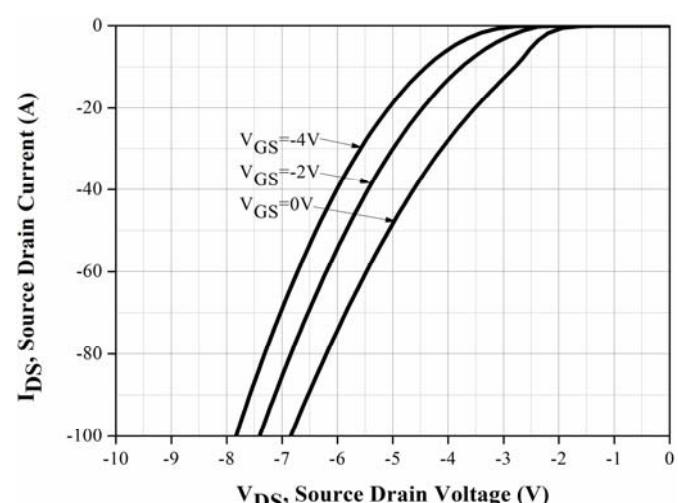
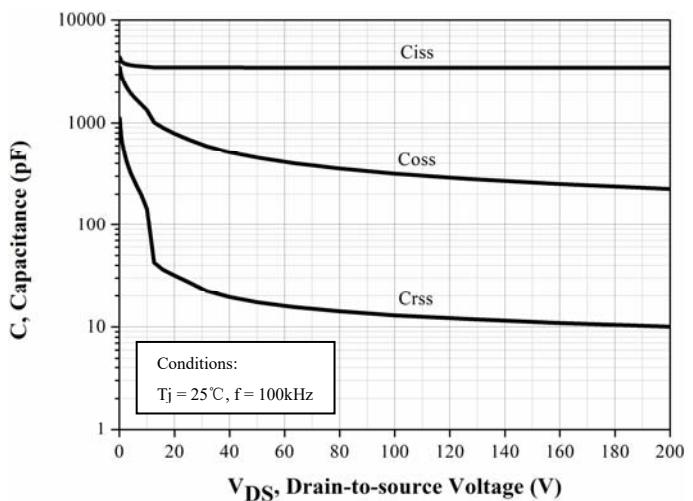
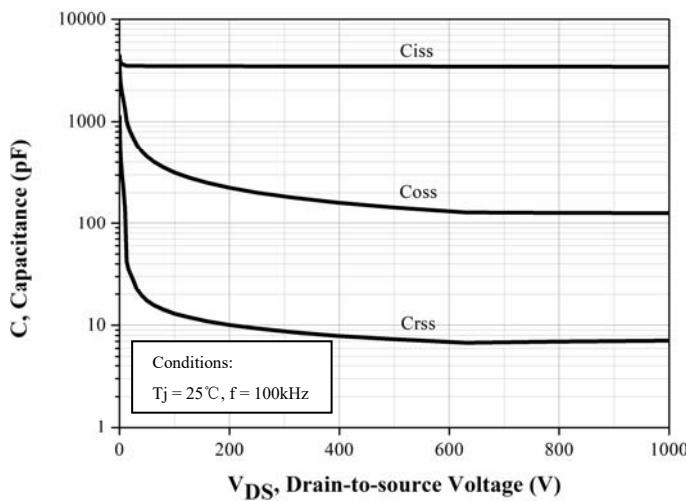
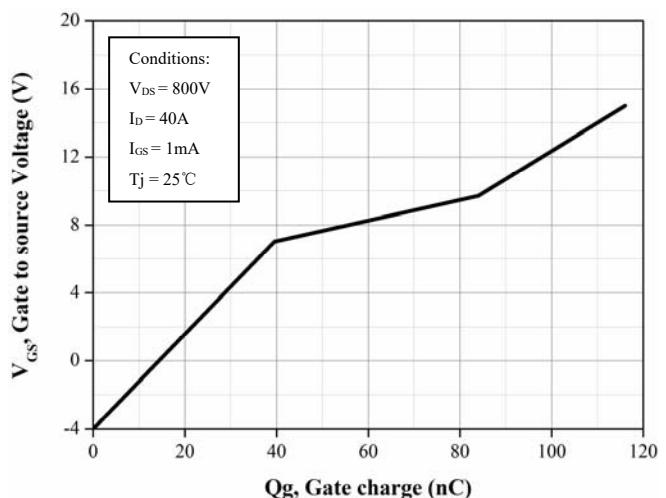
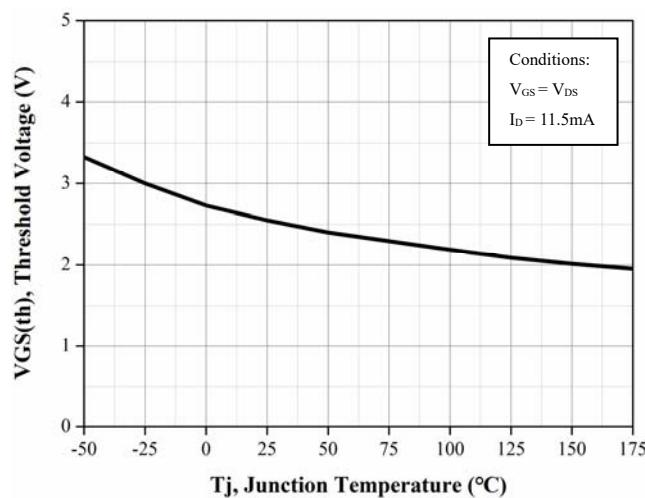
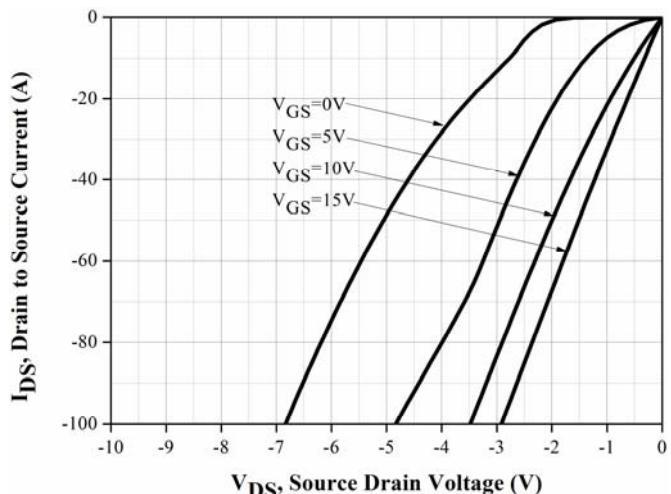
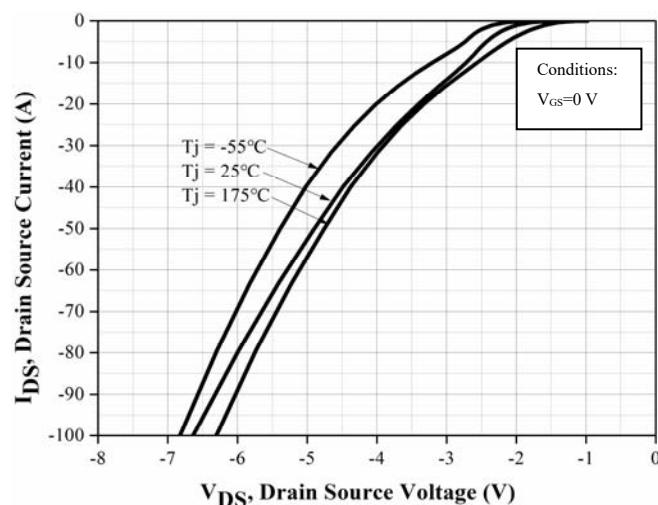


Figure 7. On-resistance vs. drain current

Figure 8. Body diode characteristic at  $T_j = 25^\circ\text{C}$



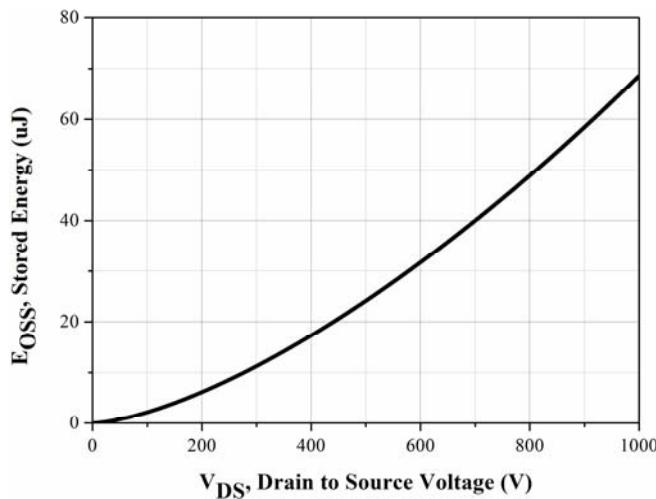


Figure 15. Output capacitor stored energy

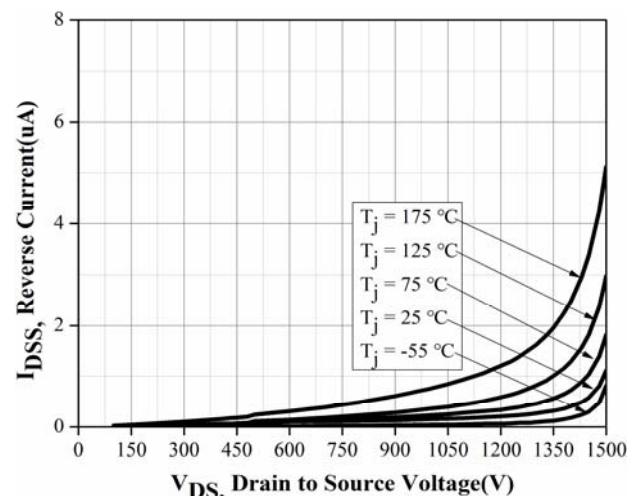
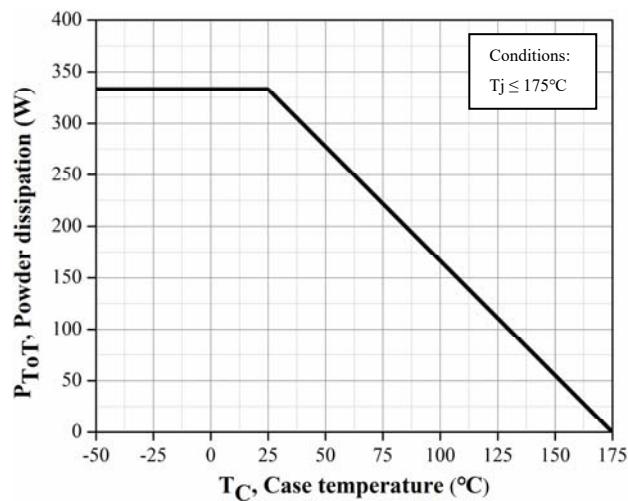
Figure 16. Reverse characteristics vs.  $T_j$ 

Figure 17. Maximum power dissipation derating vs. case temperature

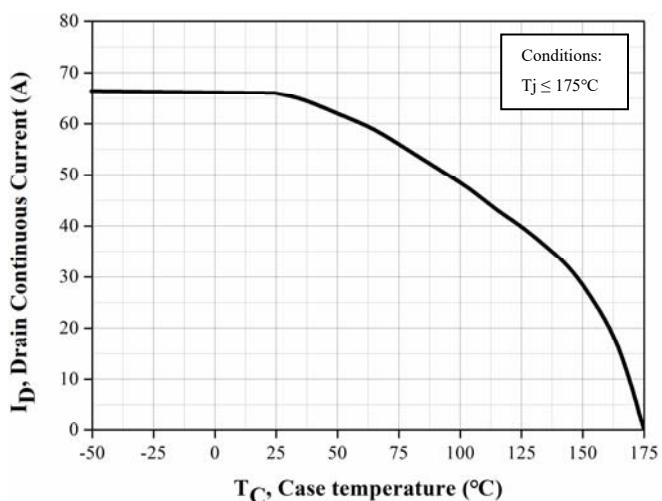


Figure 18. Continuous drain current derating vs. case temperature

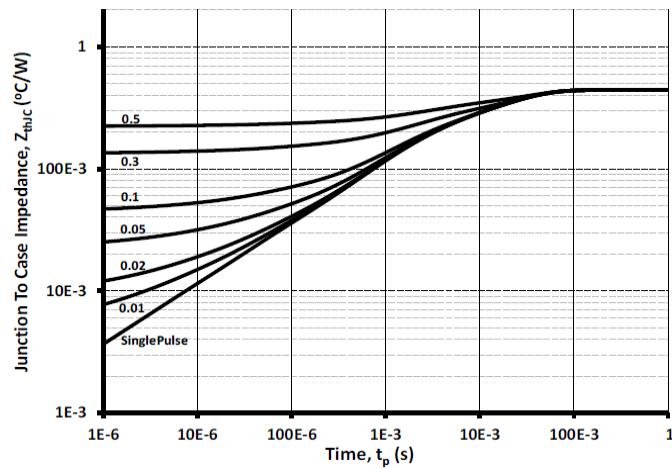


Figure 19. Transient thermal impedance (junction - case)

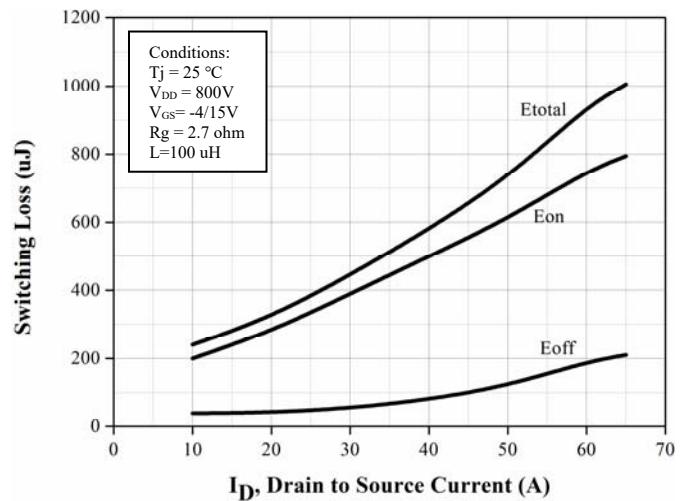


Figure 20. Clamped Inductive switching energy vs. drain current

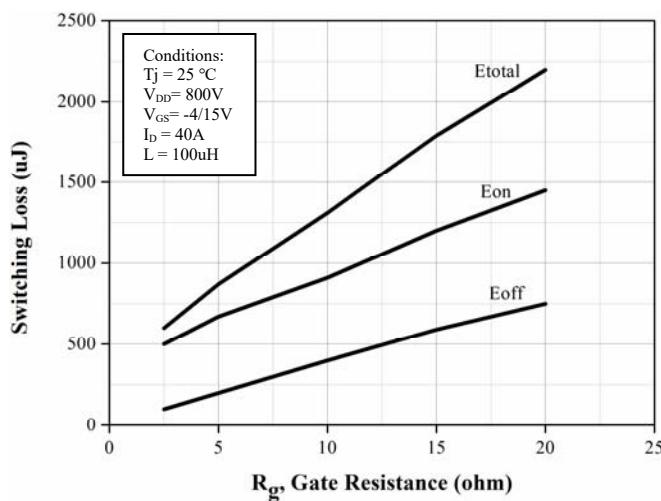


Figure 21. Clamped inductive switching energy vs.  $R_g$

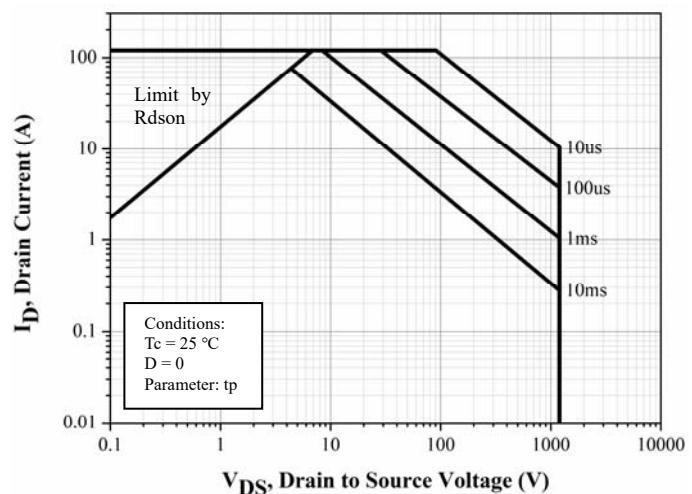


Figure 22. Safe Operating Area

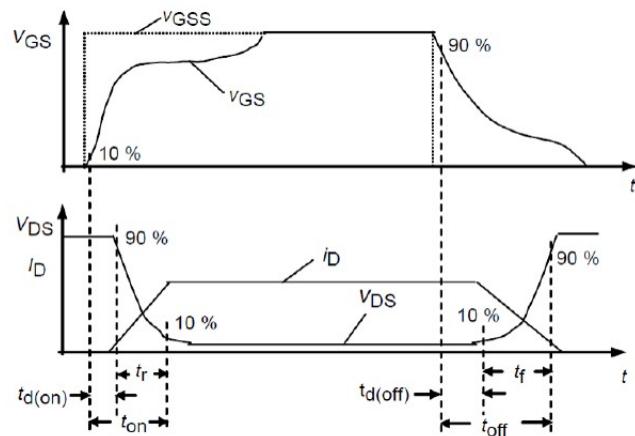


Figure 23. Switching Times Definition

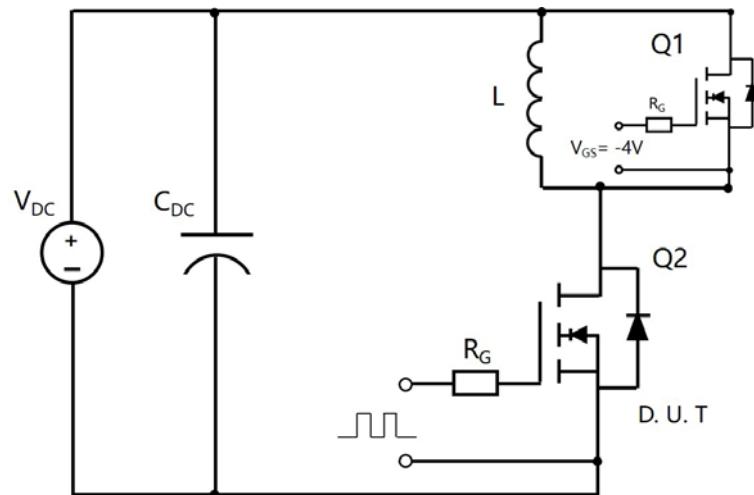
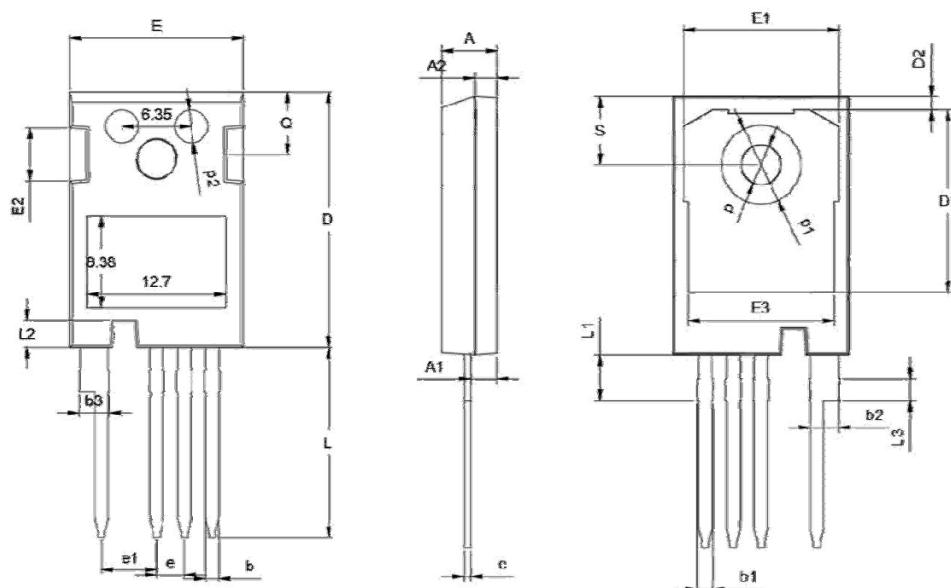


Figure 24. Clamped Inductive Switching Waveform Test Circuit

■Outline Dimensions



TO247-4L			
Dim	Min	Norm	Max
A	4.80	5.00	5.20
A1	2.30	2.40	2.50
A2	1.88	1.98	2.08
b	1.10	1.20	1.30
b1	1.20	/	1.50
b2	2.35	2.55	2.75
b3	2.45	/	2.85
c	0.55	0.60	0.65
D	23.3	23.45	23.6
D1	16.25	16.55	16.85
D2	1.00	/	1.30
e	TYP2.54		
e1	TYP5.06		
E	15.75	15.90	16.05
E1	13.80	/	14.20
E2	4.40	4.75	5.10
E3	13.00	/	13.45
L	17.34	17.49	17.64
L1	4.00	/	4.30
L2	2.35	/	2.65
L3	TYP1.98		
Q	5.60	5.80	6.00
S	6.05	/	6.30
p	TYP3.58		
p1	TYP7.18		
p2	TYP3.00		

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